

<b>Notice of References Cited</b>	Application/Control No. 10/501,791	Applicant(s)/Patent Under Reexamination KACHI ET AL.	
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*	B	US-2003/0209534	11-2003	Ferguson, Lucian G.	219/548
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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